

**Notic of Ref renc s Cit d**

Application/Control No.

09/674,266

Applicant(s)/Patent Under

Reexamination

SPECHT ET AL.

Examiner

James Martinell

Art Unit

1631

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
	B	US-			
	C	US-			
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	K	US-			
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**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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